Silicon Avalanche Photodiodes (APDs) for LIDAR, range finding and laser meters – plastic and leadless ceramic carrier packages



Excelitas' C30737 Series APDs are ideally suited to automotive LIDAR, laser meter, laser range finding and area scanning applications, providing high responsivity in the 500 – 1000 nm range.

The Excelitas C30737 series silicon avalanche photodiodes (APDs) provide high responsivity between 500nm and 1000nm, as well as extremely fast rise times at all wavelengths with a cut-off frequency >1 GHz for some versions.

Standard versions of these APDs are available in two active area sizes: 0.23 mm and 0.5 mm diameter. They are offered in a plastic throughhole T1-¾ package (C30737PH) and in leadless ceramic-carrier (LCC) surface-mount "side-looking" and "top-looking" packages (C30737CH and LH). The LH package comes with clear glass or built-in 635nm, 650nm, or 905nm filter window versions. These package varieties are ideally suited for high volume, cost-effective applications where a high gain APD is required.

The leadless, ceramic-carrier (LCC) SMD package parts (C30737CH and LH series) are available in tape-and-reel pack for SMT-compatible, RoHS-compliant reflow soldering.

Customizations of these APDs are offered to meet your design challenges. Options for these APDs include breakdown voltage selection (binning).

Key Features

- High gain at low bias voltage
- Low breakdown voltage
- Fast response, t_r ~ 200 ps for high-speed applications
- Low noise ~ 0.1pA/V Hz
- Optimized versions for high responsivity and high bandwidth
- Two standard diameters: 230µm and 500µm
- Built-in band-pass filter windows
- "Tape-and-Reel" packaging format for automated SMD pick-and-place

Applications

- Automotive LIDAR
- 905nm range-finding devices
- 635nm and 650nm laser meters
- Speed measurement
- Area scanners for safety, surveillance, automatic door opening
- Optical communication
- 3D laser scanning
- Gesture recognition



Table 1. Electrical Characteristics at T_A = 22 °C; at operating voltage-V_{op} – unfiltered devices

Parameter	C30	C30737PH-230-80 C30737CH-230-80 C30737LH-230-80			C30737PH-500-80 C30737CH-500-80 C30737LH-500-80			
	Min	Typical	Max	Min	Typical	Max	Unit	
Active Area Diameter		230			500		μm	
Peak Sensitivity Wavelength		800			800		nm	
Breakdown Voltage, V _{BR}	120		210	120		210	V	
Temperature Coefficient of V _R , for Constant M	-	0.5	-	-	0.5	-	V/°C	
Gain (M) @ 800nm	-	100	-	-	100	-		
Responsivity @ 800 nm	-	50	-	-	50	-	A/W	
Total Dark Current, I _d	-	0.05	0.5	-	0.1	1	nA	
Noise Current, I _{n, f=10kHz, Δf=1.0Hz}	-	0.1	-	-	0.1	-	pA/√Hz	
Capacitance, C _d	-	1	-	-	2	-	рF	
Rise + Fall Time, R _L =50 Ω, 10%-90%-10% points	-	0.2	-	-	0.3	-	ns	
Cut-off frequency (-3 dB)	-	1.5	-	-	1.3	-	GHz	
Storage Temperature	-40		+100	-40		+100	°C	
Operating Temperature	-20		+60	-20		+60	°C	

Parameter	C3	C30737PH-230-90 C30737CH-230-90 C30737LH-230-90			C30737PH-500-90 C30737CH-500-90 C30737LH-500-90			
	Min	Typical	Max	Min	Typical	Max	Unit	
Active Area Diameter		230	•		500		μm	
Peak Sensitivity Wavelength		900			900		nm	
Breakdown Voltage, V _{BR}	180		260	180		260	V	
Temperature Coefficient of V _R , for Constant M		1.3			1.3		V/°C	
Gain (M) @ 900 nm	-	100	-		100			
Responsivity @ 900 nm	55	60	-	55	60		A/W	
Total Dark Current, I _d	-	0.05	0.5		0.1	1	nA	
Noise Current, i _{n, f=10kHz, Δf=1.0Hz}	-	0.1	-	-	0.1	-	pA/√Hz	
Capacitance, C _d	-	0.6	-	-	1	-	pF	
Rise & Fall Time, R _L =50 Ω, 10%-90%-10% points	-	0.9	-		0.9	-	ns	
Cut-off frequency (-3 dB)	-	380	-	-	380	-	MHz	
Storage Temperature	-40		+100	-40		+100	°C	
Operating Temperature	-20		+60	-20		+60	°C	

Epitaxial Silicon Avalanche Photodiodes – Plastic and Leadless ceramic carrier packages

Table 2. Electrical Characteristics at $T_A = 22$ °C; at operating voltage- V_{op} – devices with optical bandpass filters

Parameter		C30737LH-230-81 (635nm filter #1)			C30737LH-500-81 (635nm filter #1)			
	Min	Typical	Max	Min	Typical	Max	Unit	
Active Area Diameter		230	•		500		μm	
Peak Sensitivity Wavelength		635			635		nm	
Breakdown Voltage, V _{BR}	120		210	120		210	V	
Temperature Coefficient of V _R , for Constant M	-	0.5	-	-	0.5	-	V/°C	
Gain (M) @ 635 nm	-	100	-	-	100	-		
Responsivity @ 635 nm	-	35	-	-	35	-	A/W	
Total Dark Current, I _d	-	0.05	0.5	-	0.1	1	nA	
Noise Current, i _{n, f=10kHz, Δf=1.0Hz}	-	0.1	-	-	0.1	-	pA/√Hz	
Capacitance, C _d	-	1	-	-	2	-	рF	
Rise & Fall Time, R _L =50 Ω , 10%-90%-10% points	-	0.2	-	-	0.3	-	ns	
Cut-off frequency (-3 dB)	-	1.5	-	-	1.3	-	GHz	
Storage Temperature	-40		+100	-40		+100	°C	
Operating Temperature	-20		+60	-20		+60	°C	

Parameter	C30737LH-230-92 (905nm filter #2)			C30 (90			
	Min	Typical	Max	Min	Typical	Max	Unit
Active Area Diameter		230			μm		
Peak Sensitivity Wavelength		905			905		nm
Breakdown Voltage, V _{BR}	180		260	180		260	V
Temperature Coefficient of V _R , for Constant M		1.3			1.3		V/°C
Gain (M) @ 900nm	-	100	-		100		
Responsivity @ 900 nm	55	60	-	55	60		A/W
Total Dark Current, I _d	-	0.05	0.5		0.1	1	nA
Noise Current, i _{n, f=10kHz, Δf=1.0Hz}	-	0.1	-	-	0.1	-	pA/√Hz
Capacitance, C _d	-	0.6	-	-	1	-	рF
Rise & Fall Time, R _L =50 Ω, 10%-90%-10% points	-	0.9	-	-	0.9	-	ns
Cut-off frequency (-3 dB)	-	700	-	-	580	-	MHz
Storage Temperature	-40		+100	-40		+100	°C
Operating Temperature	-20		+60	-20		+60	°C

Epitaxial Silicon Avalanche Photodiodes – Plastic and Leadless ceramic carrier packages

Parameter		C30737LH-230-83 (650nm filter #3)			C30737LH-500-83 (650nm filter #3)			
	Min	Typical	Max	Min	Typical	Max	Unit	
Active Area Diameter		230			500		μm	
Peak Sensitivity Wavelength		650			650		nm	
Breakdown Voltage, V _{BR}	120		210	120		210	V	
Temperature Coefficient of V _R , for Constant M	-	0.5	-	-	0.5	-	V/°C	
Gain (M) @ 650 nm	-	100	-	-	100	-		
Responsivity @ 650 nm	-	35	-	-	35	-	A/W	
Total Dark Current, I _d	-	0.05	0.5	-	0.1	1	nA	
Noise Current, i _{n, f=10kHz, Δf=1.0Hz}	-	0.1	-	-	0.1	-	pA/√Hz	
Capacitance, C _d	-	1	-	-	2	-	рF	
Rise & Fall Time, R _L =50 Ω, 10%-90%-10% points	-	0.2	-	-	0.3	-	ns	
Cut-off frequency (-3 dB)	-	1.5	-	-	1.3	-	GHz	
Storage Temperature	-40		+100	-40		+100	°C	
Operating Temperature	-20		+60	-20		+60	°C	

Table 3. Filter Transmission Characteristics

Filter #	1	2	3	
Nominal center wavelength	635nm ^{note 1}	905nm ^{note 2}	650nm ^{note 3}	Transmission ≥ 85%
Transmission window	623652nm		638669nm	Transmission ≥ 85%
50% cut-on wavelength	606617nm	870890nm	622634nm	
50% cut-off wavelength	657669nm	929949nm	673685nm	
Average transmission from 300 nm to bandpass region	<1% @ <593nm	<1% @ <850nm	<1% @ <608nm	
Average transmission from bandpass region to 1100 nm	<1% @ >682nm	<1% @ >979nm	<1% @ >699nm	
Wavelength drift	<+0.5nm/°C	<+0.5nm/°C	<+0.5nm/°C	for range -10°C+50°C
Typical filter thickness	0.3mm	0.3mm	0.3mm	Material: Borosilicate glass

Notes:

1. The 635nm filter is designed to work optimally with the 635nm red laser commonly used in laser meters or laser pointers.

2. The 905nm filter is designed to work optimally with the Excelitas 950nm Pulse Laser Diodes PGEW and PGA series.

3. The 650nm filter is designed to work optimally with the 650nm red laser commonly used in laser meters or laser pointers.

Figure 1–Typical Responsivity vs. wavelength.

800nm PSW = APD with 800nm peak sensitivity wavelength; 900nm PSW = APD with 900nm peak sensitivity wavelength



Figure 2– Typical capacitance vs. bias voltage



Figure 3–Typical response vs. wavelength for a 635nm filtered APD



Figure 4 Typical response vs. wavelength for a 905nm filtered APD





Figure 5–Typical gain vs. bias voltage for 800nm peak sensitivity wavelength types









Figure 8–Leadless ceramic carrier (LCC) top-looking LH package. Dimensions in mm [inches]



Epitaxial Silicon Avalanche Photodiodes – Plastic and Leadless ceramic carrier packages

Figure 9–Leadless ceramic carrier (LCC) side-looking CH package. Dimensions in mm [inches]



Table 4– Ordering Guide

	C30737	AA -	BBB -	С	D ⁽¹⁾	E ⁽²⁾⁽³⁾
Epitaxial structure Si APD	C30737					
Plastic TO-18 can (P-package)		PH -				
Leadless ceramic carrier (3 x 3 mm ² LCC) top-looking package		LH -				
Leadless ceramic carrier side-looking package		CH -				
Active area diameter = 230 μm			230 -			
Active area diameter = 500 μm			500 -			
Optimum chip response λ @ 800 nm				8		
Optimum chip response λ @ 900 nm				9		
No filter					0	
With 635 nm filter					1	
With 905 nm filter					2	
With 650 nm filter					3	
V _{bd} = 120 - 160 V						Α
V _{bd} = 160 - 200 V						В
V _{bd} = 180 - 220 V						С
V _{bd} = 220 - 260 V						D
V_{bd} = whole V_{bd} range (no V_{bd} binning)						N

(1) Filter option is only available for the LCC (LH) package option.

- (2) V_∞ binning /screening is available in these options:
 A and B are available for APD with optimum response λ @ 800nm
 C and D are available for APD with optimum response λ @ 900nm
 - N is available for all types
- (3) Bandwidth tends to be lower for lower voltage bins. Contact factory for further information.

(4) For binning please allow 2 V overlap between bins for the 800nm versions and 5 V for the 900nm versions.

Example: C30737LH-230-92C: A C30737 in the 3 x 3mm ceramic carrier package, with optimum 900nm response wavelength, with 905nm filter and selected for Vbd of 180V - 220V.

Epitaxial Silicon Avalanche Photodiodes – Plastic and Leadless ceramic carrier packages

Tape-and-Reel Shipping Pack Option

All the C30737LH (leadless ceramic carrier SMD package) series are offered in the tape-and-reel shipping pack option for quantities of 3000 units per reel; as shown in Figure 9 and 10. This packing option should be indicated at the time of order placement.

Figure 10– Tape-and-reel packing specification



Figure 11– Tape-and-reel device carrier specification



Figure 12 – Solder Reflow Diagram



RoHS Compliance

This series of APDs is designed and built to be fully compliant with the European Union Directive 2011/65/EU – Restriction of the use of certain Hazardous Substances (RoHS) in Electrical and Electronic equipment.



Warranty

A standard 12-month warranty following shipment applies.

About Excelitas Technologies

Excelitas Technologies is a global technology leader focused on delivering innovative, customized solutions to meet the lighting, detection and other high-performance technology needs of OEM customers.

Excelitas has a long and rich history of serving our OEM customer base with optoelectronic sensors and modules for more than 45 years beginning with PerkinElmer, EG&G, and RCA. The constant throughout has been our innovation and commitment to delivering the highest quality solutions to our customers worldwide.

From aerospace and defense to analytical instrumentation, clinical diagnostics, medical, industrial, and safety and security applications, Excelitas Technologies is committed to enabling our customers' success in their specialty end-markets. Excelitas Technologies has approximately 3,000 employees in North America, Europe and Asia, serving customers across the world.

Excelitas Technologies 22001 Dumberry Road

Vaudreuil-Dorion, Quebec Canada J7V 8P7 Telephone: (+1) 450.424.3300 Toll-free: (+1) 800.775.6786 Fax: (+1) 450.424.3345 detection@excelitas.com Excelitas Technologies GmbH & Co. KG Wenzel-Jaksch-Str. 31 D-65199 Wiesbaden Germany Telephone: (+49) 611 492 430 Fax: (+49) 611 492 165 detection.europe@excelitas.com Excelitas Technologies Singapore, Pte. Ltd. 8 Tractor Road Singapore 627969 Telephone: (+65) 6775 2022 (Main number) Telephone: (+65) 6770 4366 (Customer Service) Fax: (+65) 6778-1752 detection.asia@excelitas.com



For a complete listing of our global offices, visit www.excelitas.com/ContactUs © 2014 Excelitas Technologies Corp. All rights reserved. The Excelitas logo and design are registered trademarks of Excelitas Technologies Corp. All other trademarks not owned by Excelitas Technologies or its subsidiaries that are depicted herein are the property of their respective owners. Excelitas reserves the right to change this document at any time without notice and disclaims liability for editorial, pictorial or typographical errors.